

BFX 73**ULTRA HIGH FREQUENCY OSCILLATOR AND AMPLIFIER****NPN DIFFUSED SILICON PLANAR EPITAXIAL TRANSISTOR**

GENERAL DESCRIPTION - The BFX73 is an NPN double diffused silicon PLANAR epitaxial transistor. It is designed for low noise high-frequency amplifiers; 1 MHz local oscillators; non-neutralized IF amplifiers and non-saturating circuits with rise and fall time of less than 2.5 nanoseconds.

ABSOLUTE MAXIMUM RATINGS (Note 1)**Maximum Temperatures**

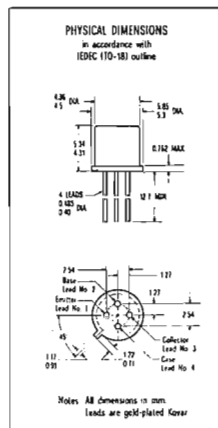
T_{STG}	Storage Temperature	- 55°C to + 200°C
T_J	Operating Junction Temperature	200°C Maximum
T_L	Lead Temperature (Soldering, 10 sec. time limit)	260°C Maximum

Maximum Power Dissipations (Notes 2 and 3)

P	Total Dissipation at 25°C Case Temperature	0.3 Watt
	at 25°C Ambient Temperature	0.2 Watt

Maximum Voltages and Current (25°C free air temperature unless otherwise noted)

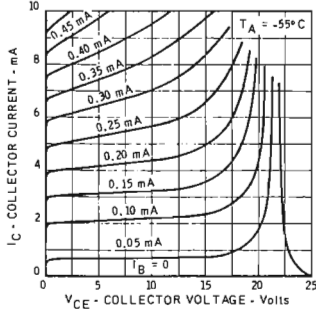
V_{CBO}	Collector to Base Voltage	30 Volts
V_{CEO}	Collector to Emitter Voltage (Note 4)	15 Volts
V_{EBO}	Emitter to Base Voltage	3 Volts
I_C	DC Collector Current	50 mA

**ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)**

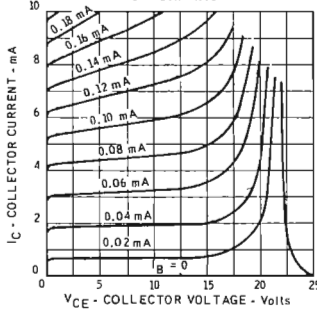
SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
h_{FE}	DC Pulse Current Gain (Note 5)	20	50			$I_C = 3 \text{ mA}$ $V_{CE} = 1 \text{ V}$
$V_{BE}(\text{sat})$	Base-Emitter Saturation Voltage (Note 5)			1	V	$I_C = 10 \text{ mA}$ $I_B = 1 \text{ mA}$
$V_{CE}(\text{sat})$	Collector-Emitter Saturation Voltage (Note 5)			0.4	V	$I_C = 10 \text{ mA}$ $I_B = 1 \text{ mA}$
I_{CBO}	Collector Cutoff Current			10	nA	$I_E = 0$ $V_{CB} = 15 \text{ V}$
$I_{CBO}(125^\circ\text{C})$	Collector Cutoff Current			1	μA	$I_E = 0$ $V_{CB} = 15 \text{ V}$
BV_{CBO}	Collector to Base Breakdown Voltage	30			V	$I_C = 1 \mu\text{A}$ $I_E = 0$
BV_{EBO}	Emitter to Base Breakdown Voltage	3			V	$I_C = 0$ $I_F = 10 \mu\text{A}$
$V_{CEO}(\text{sust})$	Collector to Emitter Sustaining Voltage (Notes 4 and 5)	15			V	$I_C = 3 \text{ mA}$ $I_B = 0$
h_{fe}	High Frequency Current Gain ($f = 100 \text{ MHz}$)	6	9			$I_C = 4 \text{ mA}$ $V_{CE} = 10 \text{ V}$
C_{ob}	Output Capacitance		1	1.7	pF	$I_E = 0$ $V_{CB} = 10 \text{ V}$
C_{ob}	Output Capacitance		1.8	3	pF	$I_E = 0$ $V_{CB} = 0$
C_{TE}	Emitter Transition Capacitance			2	pF	$I_C = 0$ $V_{EB} = 0.5 \text{ V}$
NF	Noise Figure (Note 6)		3	6	dB	$I_C = 1 \text{ mA}$ $V_{CE} = 6 \text{ V}$
P_o	Power Output ($f = 500 \text{ MHz}$)	30	40		mW	$I_C = 8 \text{ mA}$ $V_{CB} = 15 \text{ V}$
η	Collector Efficiency ($f = 500 \text{ MHz}$)	25			%	$I_C = 8 \text{ mA}$ $V_{CB} = 15 \text{ V}$
G_{pe}	Available Power Gain (neutralized) ($f = 200 \text{ MHz}$)	15	18		dB	$I_C = 6 \text{ mA}$ $V_{CE} = 12 \text{ V}$

TYPICAL ELECTRICAL CHARACTERISTICS (25°C free air temperature unless otherwise noted)

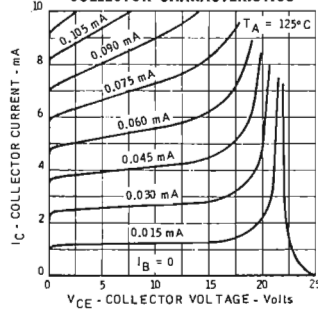
COLLECTOR CHARACTERISTICS*



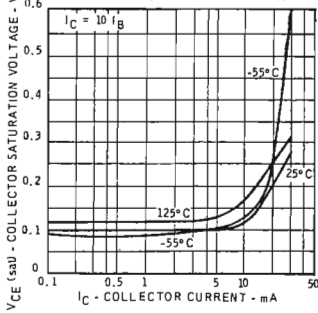
COLLECTOR CHARACTERISTICS*



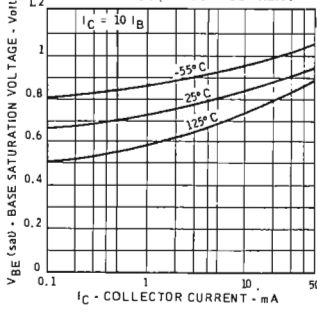
COLLECTOR CHARACTERISTICS*



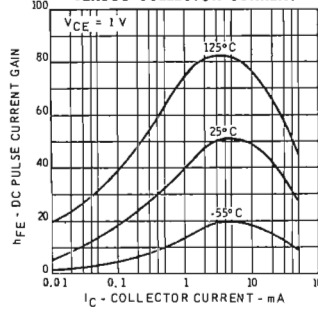
COLLECTOR SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



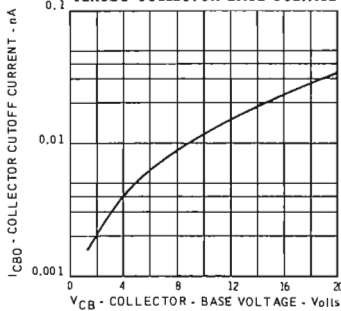
BASE SATURATION VOLTAGE VERSUS COLLECTOR CURRENT



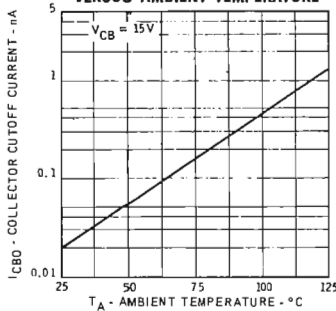
DC PULSE CURRENT GAIN VERSUS COLLECTOR CURRENT



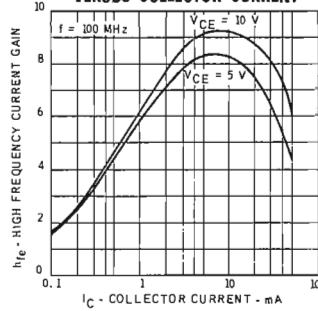
COLLECTOR CUTOFF CURRENT VERSUS COLLECTOR-BASE VOLTAGE



COLLECTOR CUTOFF CURRENT VERSUS AMBIENT TEMPERATURE



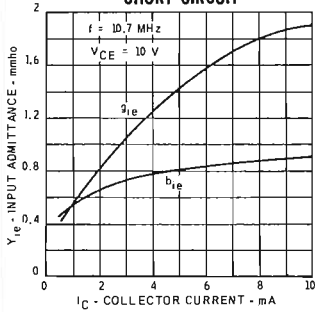
HIGH FREQUENCY CURRENT GAIN VERSUS COLLECTOR CURRENT



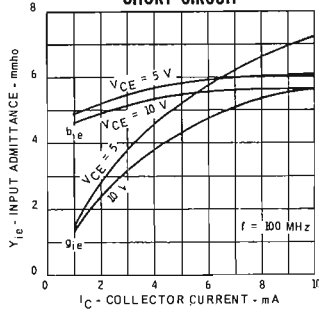
* Single family characteristics on Transistor Curve Tracer.

TYPICAL ELECTRICAL CHARACTERISTICS (25° C free air temperature unless otherwise noted)

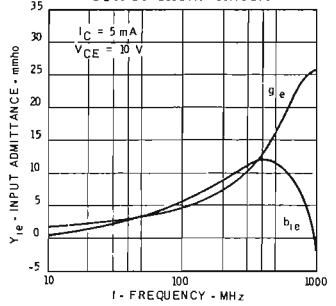
INPUT ADMITTANCE VERSUS COLLECTOR CURRENT OUTPUT SHORT CIRCUIT



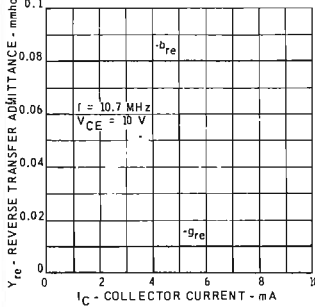
INPUT ADMITTANCE VERSUS COLLECTOR CURRENT OUTPUT SHORT CIRCUIT



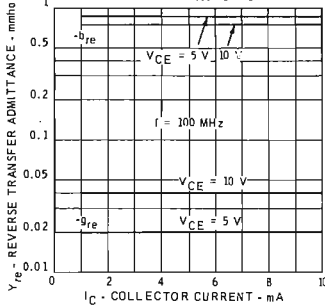
INPUT ADMITTANCE VERSUS FREQUENCY OUTPUT SHORT CIRCUIT



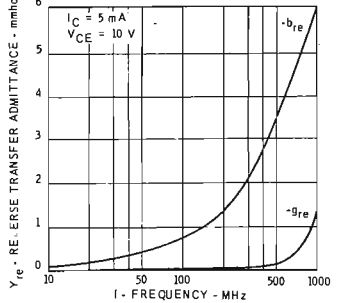
REVERSE TRANSFER ADMITTANCE VERSUS COLLECTOR CURRENT INPUT SHORT CIRCUIT



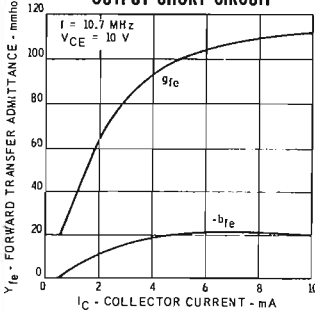
REVERSE TRANSFER ADMITTANCE VERSUS COLLECTOR CURRENT INPUT SHORT CIRCUIT



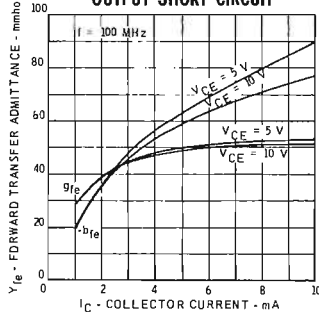
REVERSE TRANSFER ADMITTANCE VERSUS FREQUENCY INPUT SHORT CIRCUIT



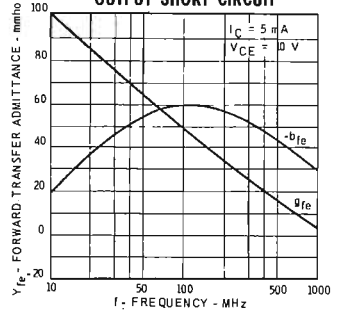
FORWARD TRANSFER ADMITTANCE VERSUS COLLECTOR CURRENT OUTPUT SHORT CIRCUIT



FORWARD TRANSFER ADMITTANCE VERSUS COLLECTOR CURRENT OUTPUT SHORT CIRCUIT

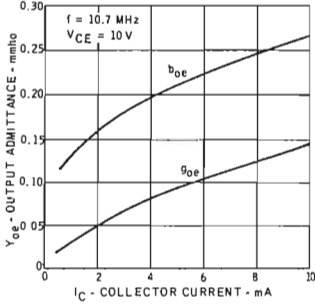


FORWARD TRANSFER ADMITTANCE VERSUS FREQUENCY OUTPUT SHORT CIRCUIT

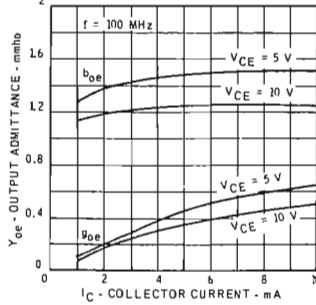


TYPICAL ELECTRICAL CHARACTERISTICS (25° C free air temperature unless otherwise noted)

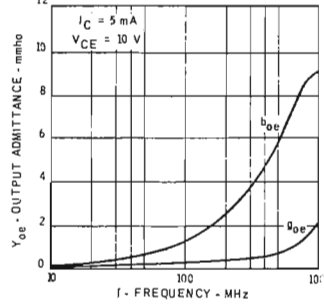
**OUTPUT ADMITTANCE VERSUS COLLECTOR CURRENT
INPUT SHORT CIRCUIT**



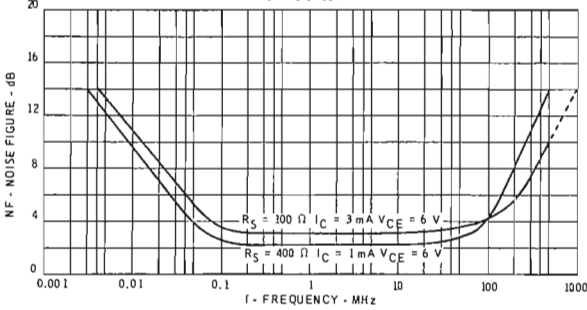
**OUTPUT ADMITTANCE VERSUS COLLECTOR CURRENT
INPUT SHORT CIRCUIT**



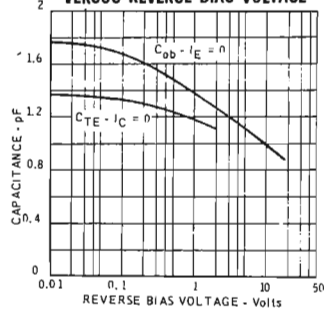
**OUTPUT ADMITTANCE VERSUS FREQUENCY
INPUT SHORT CIRCUIT**



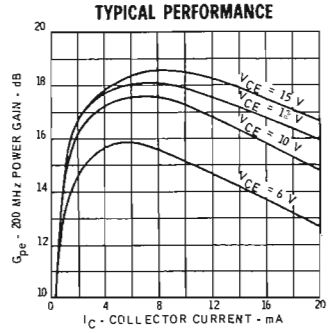
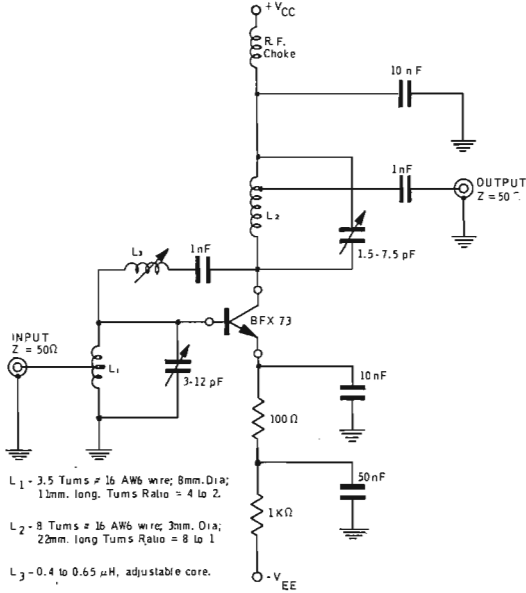
NOISE FIGURE VERSUS FREQUENCY



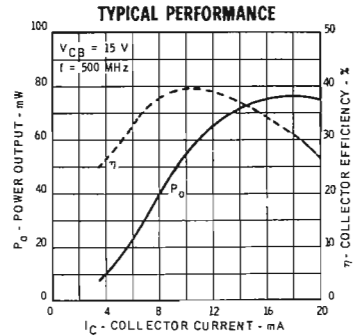
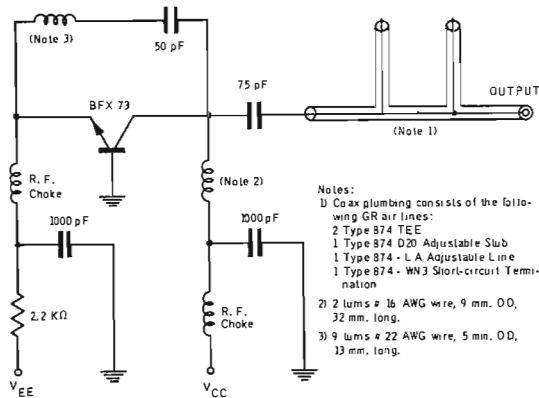
**INPUT AND OUTPUT CAPACITANCE
VERSUS REVERSE BIAS VOLTAGE**



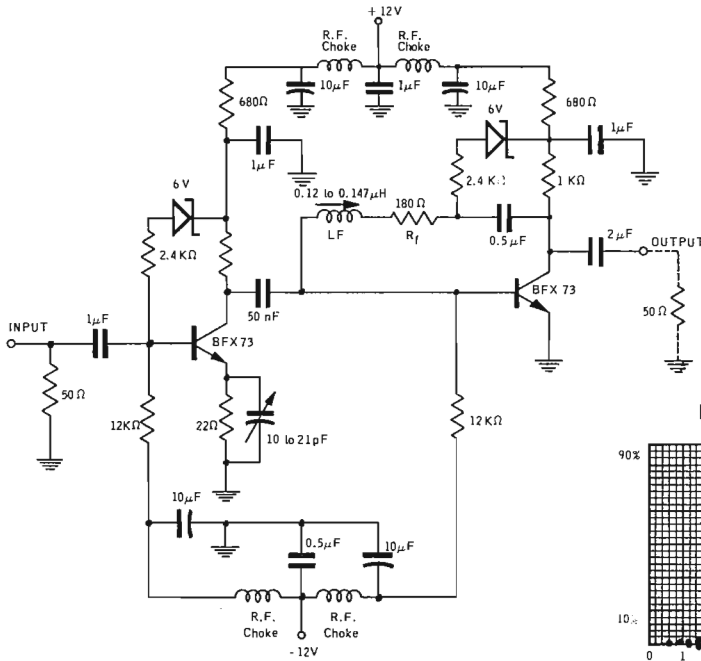
NEUTRALIZED 200 MHz POWER GAIN AMPLIFIER TEST CIRCUIT



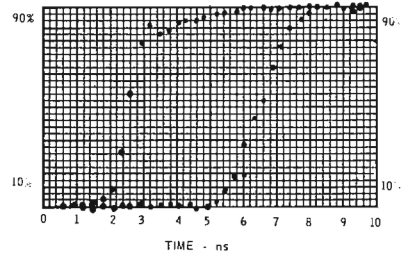
500 MHz OSCILLATOR TEST CIRCUIT



TWO STAGE VIDEO AMPLIFIER



INPUT TO OUTPUT DELAY - 4 ns.



NOTES:

- (1) These ratings are limiting values above which the serviceability of any individual semiconductor device may be impaired.
- (2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations.
- (3) These ratings give a maximum junction temperature of 200°C and junction-to-case thermal resistance of 58°C/watt (derating factor of 1.71 mW/°C); junction-to-ambient thermal resistance of 875°C/watt (derating factor of 1.14 mW/°C).
- (4) These ratings refer to a high-current point where collector-to-emitter voltage is lowest. For more information send for SGS-AR 5.
- (5) Pulse Conditions: length = 300 μsec; duty cycle = 1%.
- (6) f = 60 MHz; R_S = 400 Ω.